

Search Notes

Application/Control No.

10/757,405

Examiner

David E. Martinez

Applicant(s)/Patent under
Reexamination

TAKINOSAWA ET AL.

Art Unit

2181

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
710	62,72,301	11/17/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent,		11/17/2006	DM

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East see attached	11/17/2006	DM
eDan inventor search	11/17/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent, IBM_TDB.	11/17/2006	DM
710/2,22- 28,62,72,100,300,301,305,313".ccls.. with keywords and text search	11/17/2006	DM